

Notice of References Cited	Application/Control No. 10/697,642	Applicant(s)/Patent Under Reexamination TAKAGI ET AL.	
	Examiner Akm Enayet Ullah	Art Unit 2874	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0021874	02-2004	Shimmick, John K.	356/497
	B	US-2003/0112500	06-2003	Miki et al.	359/344
	C	US-2003/0063636	04-2003	Sasaki, Goro	372/32
	D	US-2003/0016720	01-2003	Funabashi et al.	372/96
	E	US-2002/0180944	12-2002	Fujii et al.	355/70
	F	US-2002/0018627	02-2002	Kato et al.	385/93
	G	US-6,805,494	10-2004	Miki et al.	385/88
	H	US-6,580,740	06-2003	Funabashi et al.	372/50
	I	US-6,488,419	12-2002	Kato et al.	385/93
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.